

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination DEB ET AL.	
		Examiner MARK A. FLEISCHER	Art Unit 3623	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,177,859 B2	02-2007	Pather et al.	707/3
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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